Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/534,012	NAUKKARINEN ET AL.
Examiner	Art Unit
Tu X. Nguyen	2618

	SEAR	CHED	
Class	Subclass	Date	Examiner
701	220,224	2/15/2008	TN
342	357.01,09		
	357.1		
702	150,33		
455	456.1,2,3		
	404.2		
	414.2		
	440		

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
76-07		DATE	EXMR	
Search East		2/15/2008	TN	
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